

## N-Channel Depletion-Mode DMOS FETs

### Features

- Free from Secondary Breakdown
- Low-Power Drive Requirement
- Ease of Paralleling
- Excellent Thermal Stability
- Integral Source-Drain Diode
- High Input Impedance and Low  $C_{ISS}$
- ESD Gate Protection

### General Description

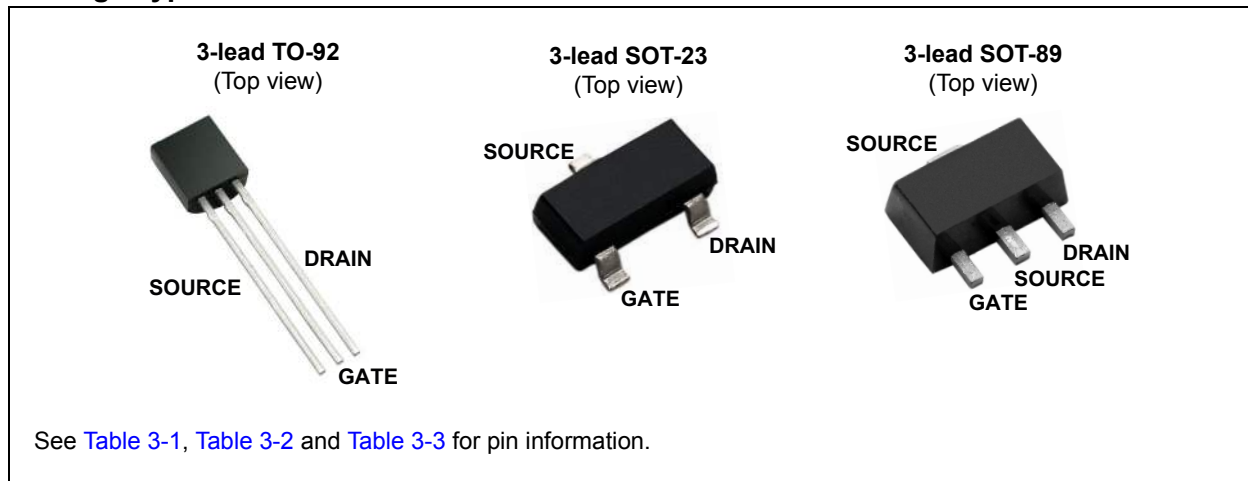
The LND150 and LND250 are high-voltage N-channel Depletion-mode (normally-on) transistors utilizing lateral DMOS technology. The gate is ESD protected.

The LND150/LND250 are ideal for high-voltage applications, such as normally-on switches, precision constant-current sources, voltage-ramp generation and amplification.

### Applications

- Solid-State Relays
- Normally-On Switches
- Converters
- Power Supply Circuits
- Constant-Current Sources
- Input Protection Circuits

### Package Types



# LND150/LND250

## 1.0 ELECTRICAL CHARACTERISTICS

### ABSOLUTE MAXIMUM RATINGS†

Drain-to-Source Voltage .....	$BV_{DSX}$
Drain-to-Gate Voltage .....	$BV_{DGX}$
Gate-to-Source Voltage .....	$\pm 20V$
Operating Ambient Temperature, $T_A$ .....	$-55^{\circ}C$ to $150^{\circ}C$
Storage Temperature, $T_S$ .....	$-55^{\circ}C$ to $150^{\circ}C$

† **Notice:** Stresses above those listed under “Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

### DC ELECTRICAL CHARACTERISTICS

**Electrical Specifications:**  $T_A = 25^{\circ}C$  unless otherwise specified. All DC parameters are 100% tested at  $25^{\circ}C$  unless otherwise stated. Pulse test: 300  $\mu s$  pulse, 2% duty cycle

Parameter	Sym.	Min.	Typ.	Max.	Unit	Conditions
Drain-to-Source Breakdown Voltage	$BV_{DSX}$	500	—	—	V	$V_{GS} = -10V, I_D = 1\text{ mA}$
Gate-to-Source Off Voltage	$V_{GS(OFF)}$	-1	—	-3	V	$V_{GS} = 25V, I_D = 100\text{ nA}$
Change in $V_{GS(OFF)}$ with Temperature	$\Delta V_{GS(OFF)}$	—	—	5	mV/ $^{\circ}C$	$V_{GS} = 25V, I_D = 100\text{ nA}$ ( <b>Note 1</b> )
Gate Body Leakage Current	$I_{GSS}$	—	—	100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
Drain-to-Source Leakage Current	$I_{D(OFF)}$	—	—	100	nA	$V_{GS} = -10V, V_{DS} = 450V$
		—	—	100	$\mu A$	$V_{DS} = 0.8V$ Maximum rating, $V_{GS} = -10V, T_A = 125^{\circ}C$ ( <b>Note 1</b> )
Saturated Drain-to-Source Current	$I_{DSS}$	1	—	3	mA	$V_{GS} = 0V, V_{DS} = 25V$
Static Drain-to-Source On-State Resistance	$R_{DS(ON)}$	—	850	1000	$\Omega$	$V_{GS} = 0V, I_D = 0.5\text{ mA}$
Change in $R_{DS(ON)}$ with Temperature	$\Delta R_{DS(ON)}$	—	—	1.2	%/ $^{\circ}C$	$V_{GS} = 0V, I_D = 0.5\text{ mA}$ ( <b>Note 1</b> )

**Note 1:** Specification is obtained by characterization and is not 100% tested.

## AC ELECTRICAL CHARACTERISTICS

**Electrical Specifications:**  $T_A = 25^\circ\text{C}$  unless otherwise specified. Specification is obtained by characterization and is not 100% tested.

Parameter	Sym.	Min.	Typ.	Max.	Unit	Conditions
Forward Transconductance	$G_{FS}$	1	2	—	mmho	$V_{DS} = 0\text{V}$ , $I_D = 1\text{ mA}$
Input Capacitance	$C_{ISS}$	—	7.5	10	pF	$V_{GS} = -10\text{V}$ , $V_{DS} = 25\text{V}$ , $f = 1\text{ MHz}$
Common Source Output Capacitance	$C_{OSS}$	—	2	3.5	pF	
Reverse Transfer Capacitance	$C_{RSS}$	—	0.5	1	pF	
Turn-On Delay Time	$t_{d(ON)}$	—	0.09	—	ns	$V_{DD} = 25\text{V}$ , $I_D = 1\text{ mA}$ , $R_{GEN} = 25\Omega$
Rise Time	$t_r$	—	0.45	—	ns	
Turn-Off Delay Time	$t_{d(OFF)}$	—	0.1	—	ns	
Fall Time	$t_f$	—	1.3	—	ns	
<b>DIODE PARAMETER</b>						
Diode Forward Voltage Drop	$V_{SD}$	—	—	0.9	V	$V_{GS} = -10\text{V}$ , $I_{SD} = 1\text{ mA}$ (Note 1)
Reverse Recovery Time	$t_{rr}$	—	200	—	ns	$V_{GS} = -10\text{V}$ , $I_{SD} = 1\text{ mA}$

**Note 1:** Unless otherwise stated, all DC parameters are 100% tested at  $+25^\circ\text{C}$ . Pulse test: 300  $\mu\text{s}$  pulse, 2% duty cycle.

## TEMPERATURE SPECIFICATIONS

Parameter	Sym.	Min.	Typ.	Max.	Unit	Conditions
<b>TEMPERATURE RANGE</b>						
Operating Ambient Temperature	$T_A$	-55	—	+150	$^\circ\text{C}$	
Storage Temperature	$T_S$	-55	—	+150	$^\circ\text{C}$	
<b>PACKAGE THERMAL RESISTANCE</b>						
3-lead TO-92	$\theta_{JA}$	—	132	—	$^\circ\text{C/W}$	
3-lead SOT-23	$\theta_{JA}$	—	203	—	$^\circ\text{C/W}$	
3-lead SOT-89	$\theta_{JA}$	—	133	—	$^\circ\text{C/W}$	

## THERMAL CHARACTERISTICS

Package	$I_D$ (Note 1) (Continuous) (mA)	$I_D$ (Pulsed) (A)	Power Dissipation at $T_A = 25^\circ\text{C}$ (W)	$I_{DR}$ (mA)	$I_{DRM}$ (Note 1) (A)
3-lead TO-92	30	30	0.74	30	30
3-lead SOT-23	13	30	0.36	13	30
3-lead SOT-89	30	30	1.6 (Note 2)	30	30

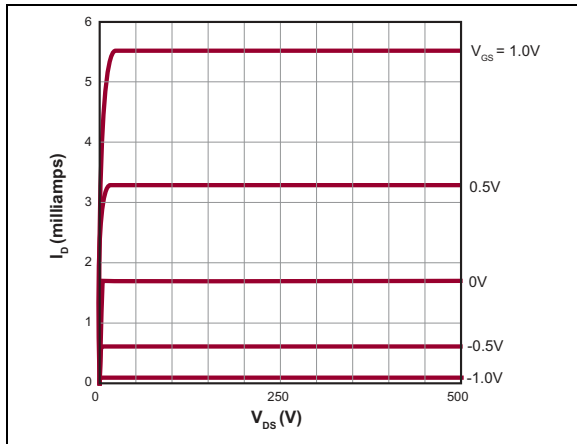
**Note 1:**  $I_D$  (continuous) is limited by maximum rated  $T_J$ .

**2:**  $T_A = 25^\circ\text{C}$ . Mounted on an FR4 Board, 25 mm x 25 mm x 1.57 mm.

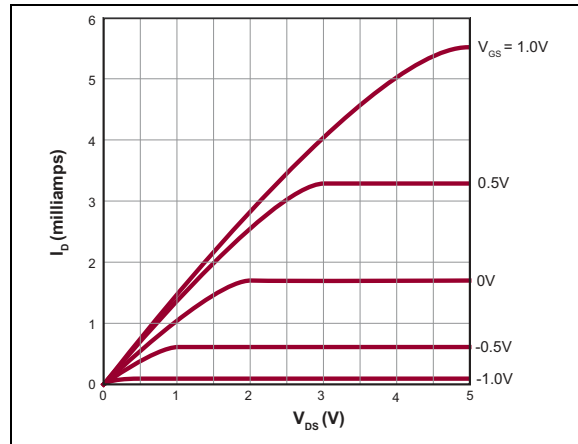
# LND150/LND250

## 2.0 TYPICAL PERFORMANCE CURVES

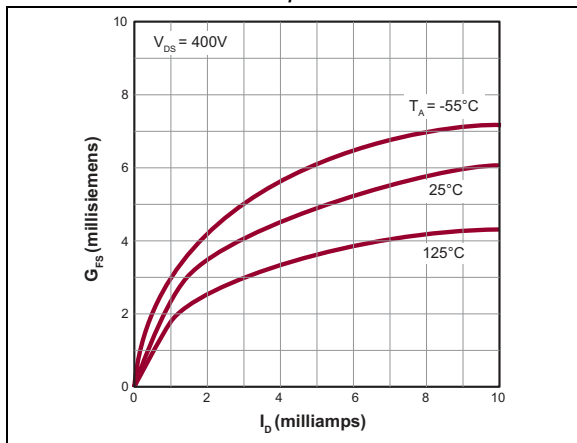
**Note:** The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g. outside specified power supply range) and therefore outside the warranted range.



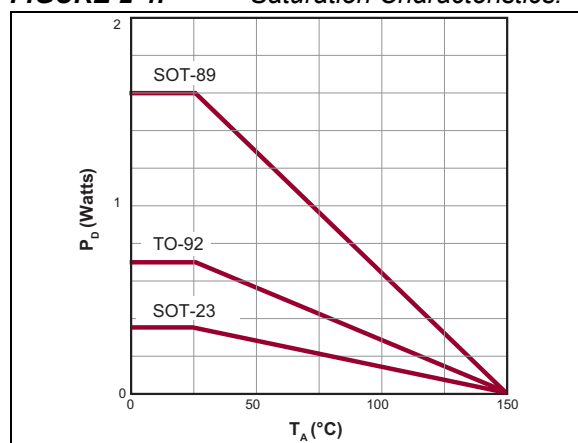
**FIGURE 2-1:** Output Characteristics.



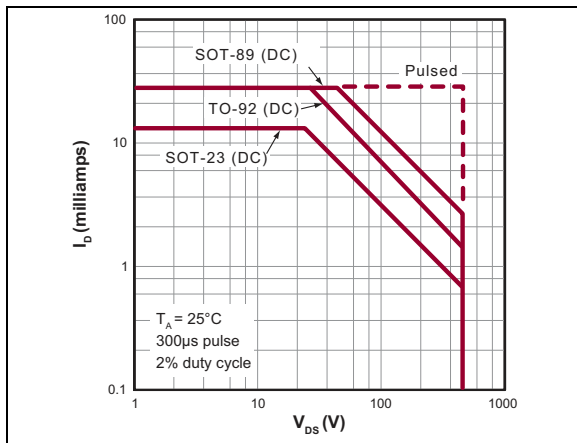
**FIGURE 2-4:** Saturation Characteristics.



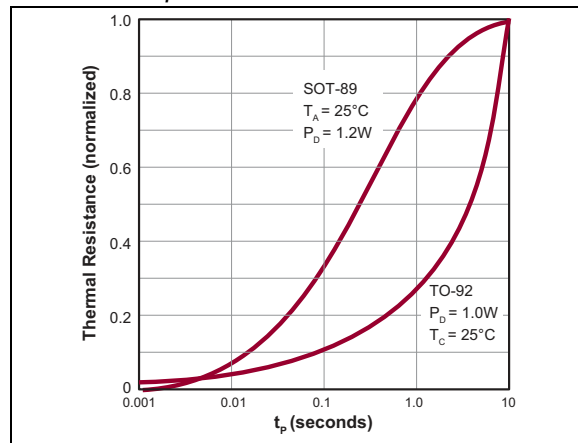
**FIGURE 2-2:** Transconductance vs. Drain Current.



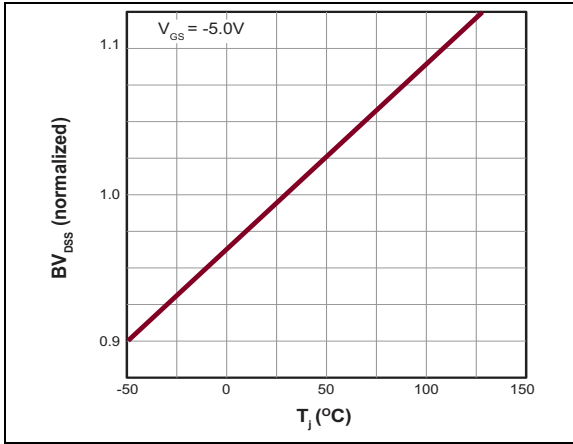
**FIGURE 2-5:** Power Dissipation vs. Ambient Temperature.



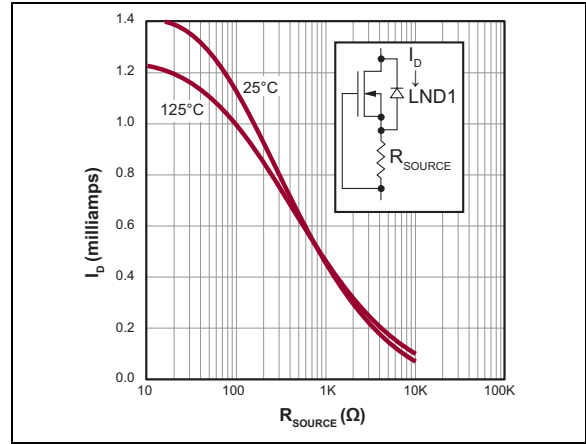
**FIGURE 2-3:** Maximum Rated Safe Operating Area.



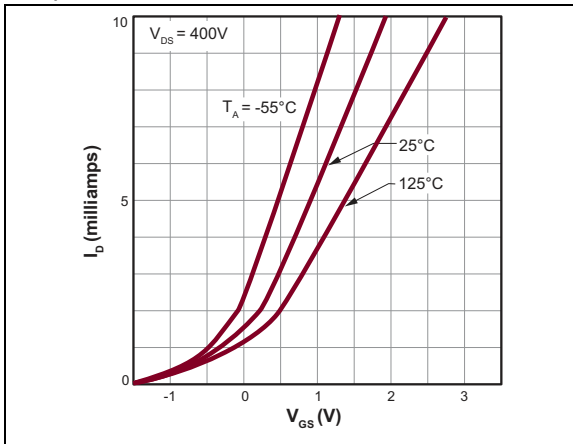
**FIGURE 2-6:** Thermal Response Characteristics.



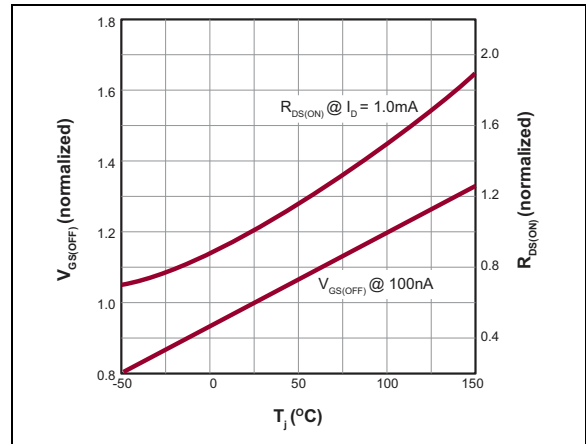
**FIGURE 2-7:**  $BV_{DSS}$  Variation with Temperature.



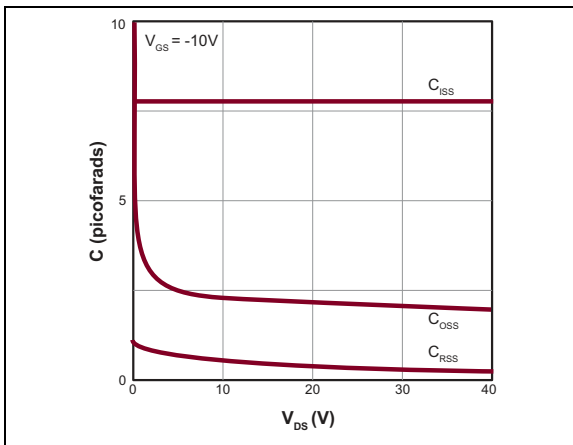
**FIGURE 2-10:** Drain Current vs.  $R_{SOURCE}$ .



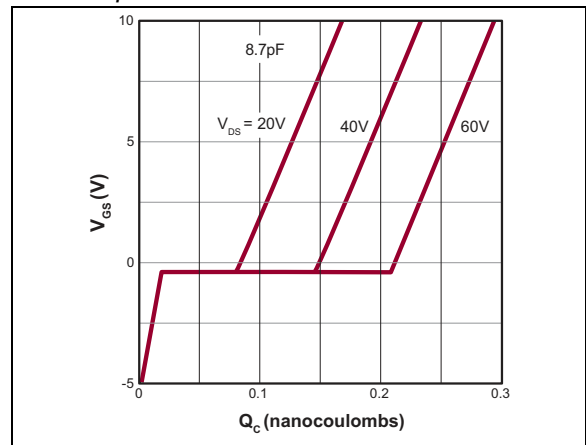
**FIGURE 2-8:** Transfer Characteristics.



**FIGURE 2-11:**  $V_{GS(OFF)}$  and  $R_{DS}$  Variation with Temperature.



**FIGURE 2-9:** Capacitance vs. Drain-to-Source Voltage.



**FIGURE 2-12:** Gate Drive Dynamic Characteristics.

# LND150/LND250

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## 3.0 PIN DESCRIPTION

The details on the pins of LND150/LND250 are listed on [Table 3-1](#), [Table 3-2](#) and [Table 3-3](#). Refer to [Package Types](#) for the location of pins.

**TABLE 3-1: TO-92 PIN FUNCTION TABLE**

Pin Number	Pin Name	Description
1	SOURCE	SOURCE
2	GATE	GATE
3	DRAIN	DRAIN

**TABLE 3-2: SOT-23 PIN FUNCTION TABLE**

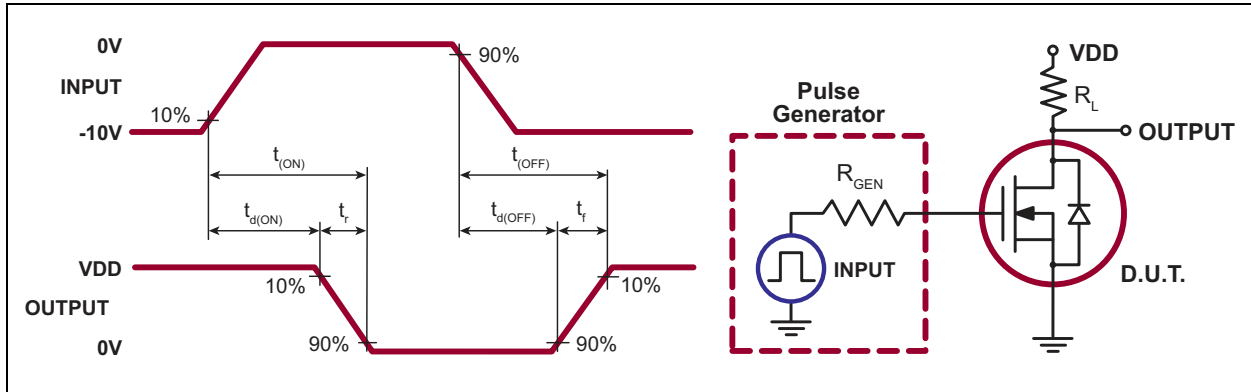
Pin Number	Pin Name	Description
1	GATE	GATE
2	DRAIN	DRAIN
3	SOURCE	SOURCE

**TABLE 3-3: SOT-89 PIN FUNCTION TABLE**

Pin Number	Pin Name	Description
1	GATE	GATE
2, 4	SOURCE	SOURCE
3	DRAIN	DRAIN

## 4.0 FUNCTIONAL DESCRIPTION

Figure 4-1 illustrates the switching waveforms and test circuit for LND150/LND250.



**FIGURE 4-1:** Switching Waveforms and Test Circuit.

**TABLE 4-1: PRODUCT SUMMARY**

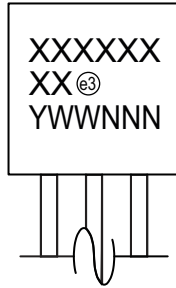
$BV_{DSX}/BV_{DGX}$ (V)	$R_{DS(ON)}$ (Maximum) ( $\Omega$ )	$I_{DSS(ON)}$ (Minimum) (mA)
500	1000	1

# LND150/LND250

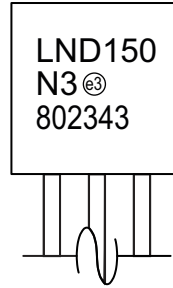
## 5.0 PACKAGING INFORMATION

### 5.1 Package Marking Information

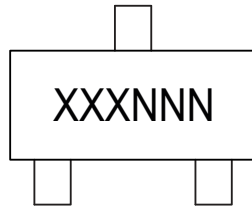
3-lead TO-92



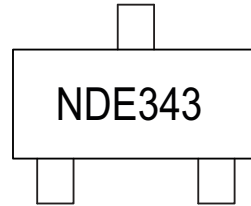
Example



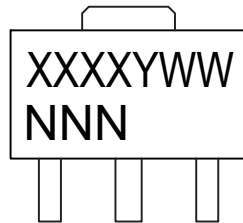
3-lead SOT-23



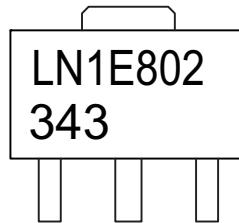
Example



3-lead SOT-89



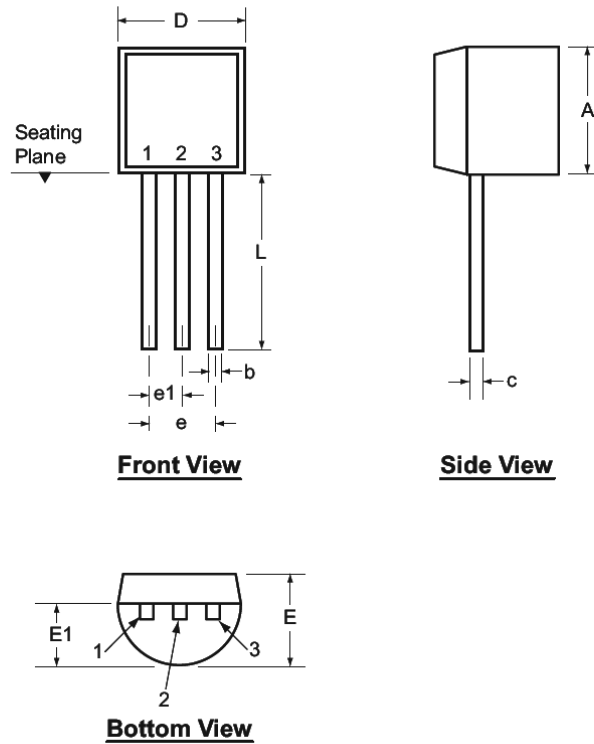
Example



<b>Legend:</b>	XX...X	Product Code or Customer-specific information
	Y	Year code (last digit of calendar year)
	YY	Year code (last 2 digits of calendar year)
	WW	Week code (week of January 1 is week '01')
	NNN	Alphanumeric traceability code
	(e3)	Pb-free JEDEC® designator for Matte Tin (Sn)
	*	This package is Pb-free. The Pb-free JEDEC designator (e3) can be found on the outer packaging for this package.
<b>Note:</b>	In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for product code or customer-specific information. Package may or not include the corporate logo.	



## 3-Lead TO-92 Package Outline (L/LL/N3)



Note: For the most current package drawings, see the Microchip Packaging Specification at [www.microchip.com/packaging](http://www.microchip.com/packaging).

Symbol		A	b	c	D	E	E1	e	e1	L
Dimensions (inches)	MIN	.170	.014 <sup>†</sup>	.014 <sup>†</sup>	.175	.125	.080	.095	.045	.500
	NOM	-	-	-	-	-	-	-	-	-
	MAX	.210	.022 <sup>†</sup>	.022 <sup>†</sup>	.205	.165	.105	.105	.055	.610*

JEDEC Registration TO-92.

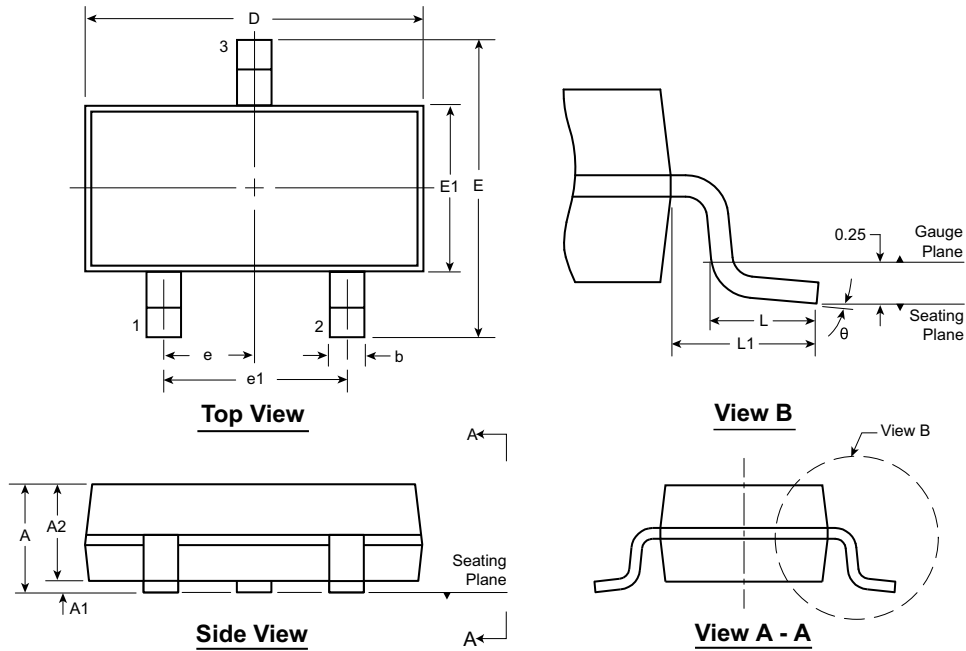
\* This dimension is not specified in the JEDEC drawing.

† This dimension differs from the JEDEC drawing.

Drawings not to scale.

# LND150/LND250

## 3-Lead TO-236AB (SOT-23) Package Outline (K1/T) 2.90x1.30mm body, 1.12mm height (max), 1.90mm pitch



Note: For the most current package drawings, see the Microchip Packaging Specification at [www.microchip.com/packaging](http://www.microchip.com/packaging).

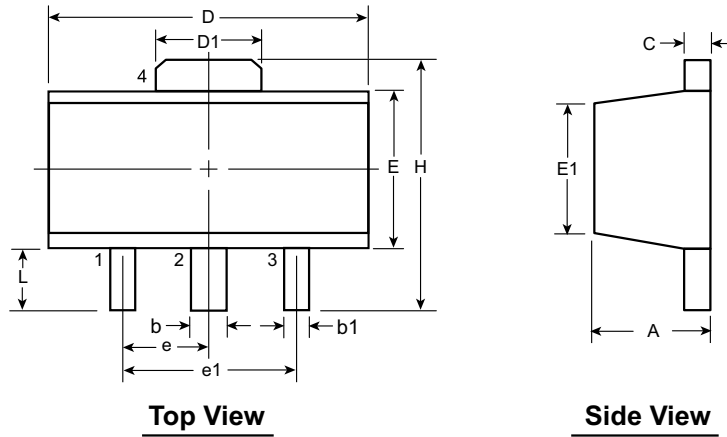
Symbol	A	A1	A2	b	D	E	E1	e	e1	L	L1	$\theta$
Dimension (mm)	MIN	0.89	0.01	0.88	0.30	2.80	2.10	1.20	0.95 BSC	1.90 BSC	0.54 REF	0.20 <sup>†</sup>
	NOM	-	-	0.95	-	2.90	-	1.30				0.50
	MAX	1.12	0.10	1.02	0.50	3.04	2.64	1.40				0.60

JEDEC Registration TO-236, Variation AB, Issue H, Jan. 1999.

<sup>†</sup> This dimension differs from the JEDEC drawing.

**Drawings not to scale.**

## 3-Lead TO-243AA (SOT-89) Package Outline (N8)



Note: For the most current package drawings, see the Microchip Packaging Specification at [www.microchip.com/packaging](http://www.microchip.com/packaging).

Symbol		A	b	b1	C	D	D1	E	E1	e	e1	H	L	
Dimensions (mm)	MIN	1.40	0.44	0.36	0.35	4.40	1.62	2.29	2.00 <sup>†</sup>	1.50 BSC	3.00 BSC	3.94	0.73 <sup>†</sup>	
	NOM	-	-	-	-	-	-	-	-			-	-	-
	MAX	1.60	0.56	0.48	0.44	4.60	1.83	2.60	2.29			-	-	4.25

JEDEC Registration TO-243, Variation AA, Issue C, July 1986.

<sup>†</sup> This dimension differs from the JEDEC drawing

Drawings not to scale.

# LND150/LND250

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NOTES:

## APPENDIX A: REVISION HISTORY

### Revision A (August 2018)

- Converted and merged Supertex Doc#s DSFP-LND150 and DSFP-LND250 to Microchip DS20005454
- Changed the package marking format
- Removed the TO-92 N3 P005 media type
- Added some sections to comply with the standard Microchip Technology Inc. documentation format
- Made minor text changes throughout the document

# LND150/LND250

## PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

<u>PART NO.</u>	<u>XX</u>	-	<u>X</u>	-	<u>X</u>
Device	Package Options		Environmental		Media Type
Devices:	LND150 = N-Channel Depletion-Mode DMOS FET LND250 = N-Channel Depletion-Mode DMOS FET				
Packages:	N3 = 3-lead TO-92 K1 = 3-lead SOT-23 N8 = 3-lead SOT-89				
Environmental:	G = Lead (Pb)-free/ROHS-compliant package				
Media Types:	(blank) = 1000/Bag for an N3 package = 3000/Reel for a K1 package = 2000/Reel for an N8 package P002 = 2000/Reel for an N3 package P003 = 2000/Reel for an N3 package P013 = 2000/AMMO Pack for an N3 package P014 = 2000/AMMO Pack for an N3 package				
<b>Note: LND250 is only offered in 3-lead SOT-23 package.</b>					

### Examples:

- a) LND150N3-G: N-Channel Depletion-Mode DMOS FET, 3-lead TO-92, 1000/Bag
- b) LND150K1-G: N-Channel Depletion-Mode DMOS FET, 3-lead SOT-23, 3000/Reel
- c) LND150N8-G: N-Channel Depletion-Mode DMOS FET, 3-lead TO-92, 2000/Reel
- d) LND150N3-G-P002: N-Channel Depletion-Mode DMOS FET, 3-lead TO-92, 2000/Reel

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**Note the following details of the code protection feature on Microchip devices:**

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
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